UNISONIC TECHNOLOGIES CO., LTD

4N65-HC **Preliminary** Power MOSFET

4A, 650V N-CHANNEL **POWER MOSFET**

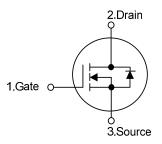
DESCRIPTION

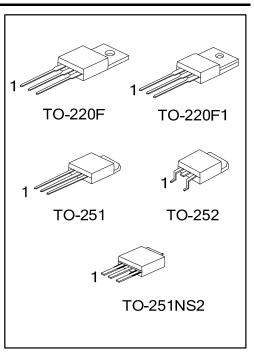
The UTC 4N65-HC is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)}$ < 2.4 Ω @ V_{GS} = 10 V, I_D = 2.0 A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

SYMBOL

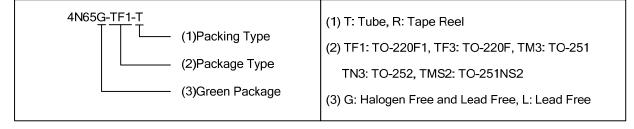




ORDERING INFORMATION

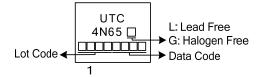
Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
4N65L-TF1-T	4N65G-TF1-T	TO-220F1	G	D	S	Tube	
4N65L-TF3-T	4N65G-TF3-T	TO-220F	G	D	S	Tube	
4N65L-TM3-T	4N65G-TM3-T	TO-251	G	D	S	Tube	
4N65L-TN3-R	4N65G-TN3-R	TO-252	G	D	S	Tape Reel	
4N65L-TMN2-T	4N65G-TMN2-T	TO-251NS2	G	D	S	Tube	

Pin Assignment: G: Gate D: Drain S: Source Note:



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■ MARKING



■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	650	V
Gate-Source Voltage		V_{GSS}	±30	V
Continuous Drain Current		I_{D}	4	Α
Pulsed Drain Current (Note 2)		I_{DM}	16	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	80	mJ
Peak Diode Recovery dv/c	eak Diode Recovery dv/dt (Note 4)		3.36	V/ns
	TO-220F/TO-220F1		35	W
Power Dissipation	TO-251/TO-252 TO-251NS2	P_D	50	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 10mH, I_{AS} = 4.0A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
- 4. $I_{SD} \le 4.0$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C

■ THERMAL DATA

PARAMETER		SYMBOL RATING		UNIT
Junction to Ambient	TO-220F/TO-220F1		62.5	°C/W
	TO-251/TO-252 TO-251NS2	θ_{JA}	110	°C/W
Junction to Case	TO-220F/TO-220F1		3.5	°C/W
	TO-251/TO-252 TO-251NS2	θ _{JC}	2.5	°C/W

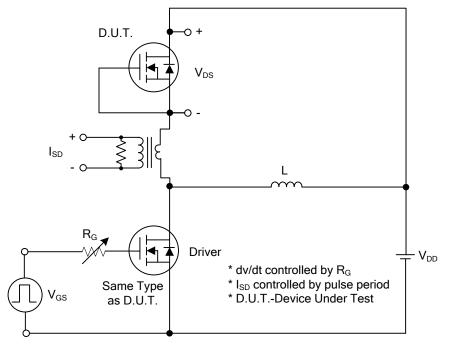
■ ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	650			V
Drain-Source Leakage Current		I_{DSS}	$V_{DS} = 650V, V_{GS} = 0V$			10	μΑ
Gate- Source Leakage Current	Forward	GSS	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
	Reverse		$V_{GS} = -30V, V_{DS} = 0V$			-100	nA
ON CHARACTERISTICS						•	,
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 2.0A$		1.91	2.4	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}			520	720	pF
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0 MHz		75	90	pF
Reverse Transfer Capacitance		C_{RSS}			13	20	pF
SWITCHING CHARACTERISTIC	S						
Total Gate Charge (Note 1)		Q_G	V _{DS} =300V, V _{GS} =10V, I _D =3.0A (Note 1, 2)		19	25	nC
Gate-Source Charge		Q_GS			3.5		nC
Gate-Drain Charge		Q_GD	(14010-1, 2)		5.8		nC
Turn-On Delay Time (Note 1)		$t_{D(ON)}$			9.0		ns
Turn-On Rise Time		t_R	V_{DD} =50V, V_{GS} =10V, I_{D} =0.5A,		22		ns
Turn-Off Delay Time		$t_{D(OFF)}$	$R_G = 25\Omega$ (Note 1, 2)		53		ns
Turn-Off Fall Time		t_{F}			42		ns
DRAIN-SOURCE DIODE CHARA	CTERISTIC	CS AND MA	XIMUM RATINGS				
Maximum Continuous Drain-Source Diode		Is				4	Α
Forward Current						4	^
Maximum Pulsed Drain-Source Diode		I _{SM}				16	Α
Forward Current						10	^
Drain-Source Diode Forward Voltage		V_{SD}	I _S =4.0A , V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time		t _{rr}	 I _S =4.0A , V _{GS} =0V di/dt=100A/μs		290		ns
Body Diode Reverse Recovery Charge		Q_{rr}	15-7.0/1, νως-0ν απαι-100//μ5		1.65		μC

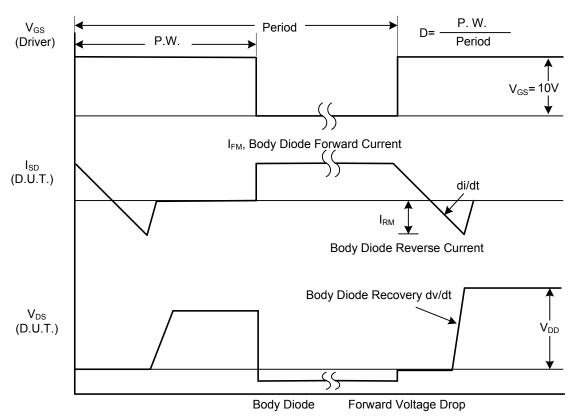
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

^{2.} Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

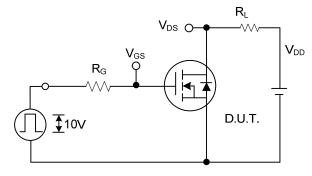


Peak Diode Recovery dv/dt Test Circuit

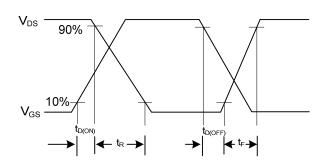


Peak Diode Recovery dv/dt Waveforms

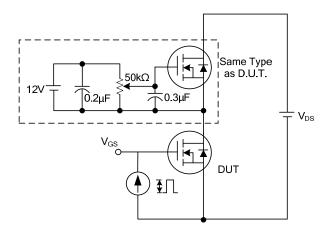
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



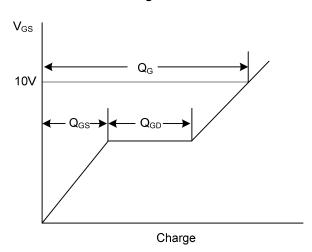
Switching Test Circuit



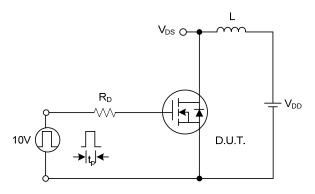
Switching Waveforms



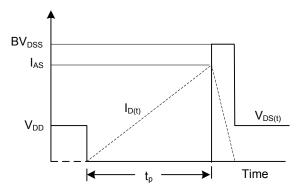
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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